Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,635	CHO ET AL.	
Examiner	Art Unit	
HELEN SHIBRU	2621	

SEARCHED			
Class	Subclass	Date	Examiner
386	95, 124- 126	8/31/2006	нѕ
<u></u>			
			,
,			
٠. ا			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	- 1		
1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text searching	8/31/2006	нѕ
Modified Dearch	01/08/06	(f)
Martiel Sear en & Searon report	1	09/01/0
Encluded in Appl 833		